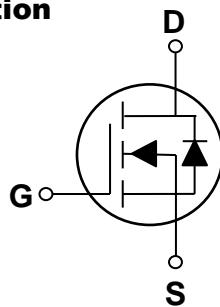


## General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

## PPAK5X6 Pin Configuration



BVDSS	RDS(ON)	ID
100V	9.2mΩ	62A

## Features

- 100V,62A, RDS(ON) =9.2mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

## Applications

- Networking
- Load Switch
- LED applications
- Quick Charger



## Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	100	V
$V_{GS}$	Gate-Source Voltage	+20 / -12	V
$I_D$	Drain Current – Continuous ( $T_c=25^\circ\text{C}$ ) (Chip Limitation)	62	A
	Drain Current – Continuous ( $T_c=100^\circ\text{C}$ ) (Chip Limitation)	39.2	A
$I_{DM}$	Drain Current – Pulsed <sup>1</sup>	248	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	211	mJ
IAS	Single Pulse Avalanche Current <sup>2</sup>	65	A
$P_D$	Power Dissipation ( $T_c=25^\circ\text{C}$ )	125	W
	Power Dissipation – Derate above 25°C	1	W/°C
$T_{STG}$	Storage Temperature Range	-50 to 150	°C
$T_J$	Operating Junction Temperature Range	-50 to 150	°C

## Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	1	°C/W

**Electrical Characteristics ( $T_J=25\text{ }^{\circ}\text{C}$ , unless otherwise noted)**
**Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$	100	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	$BV_{DSS}$ Temperature Coefficient	Reference to $25\text{ }^{\circ}\text{C}$ , $I_D=1\text{mA}$	---	0.054	---	$\text{V}/^{\circ}\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=100\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=25\text{ }^{\circ}\text{C}$	---	---	1	$\mu\text{A}$
		$V_{DS}=80\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=125\text{ }^{\circ}\text{C}$	---	---	10	$\mu\text{A}$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=+20\text{V}$ , $V_{DS}=0\text{V}$	---	---	100	nA

**On Characteristics**

$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}$ , $I_D=15\text{A}$	---	7.2	9.2	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}$ , $I_D=8\text{A}$	---	10.8	14	$\text{m}\Omega$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250\mu\text{A}$	1.2	1.6	2.5	V
			---	-5.5	---	$\text{mV}/^{\circ}\text{C}$
$g_{fs}$	Forward Transconductance	$V_{DS}=10\text{V}$ , $I_D=3\text{A}$	---	11	---	S

**Dynamic and switching Characteristics**

$Q_g$	Total Gate Charge <sup>3, 4</sup>	$V_{DS}=80\text{V}$ , $V_{GS}=10\text{V}$ , $I_D=8.5\text{A}$	---	39.7	80	nC
$Q_{gs}$	Gate-Source Charge <sup>3, 4</sup>		---	5.4	10	
$Q_{gd}$	Gate-Drain Charge <sup>3, 4</sup>		---	11.2	22	
$T_{d(on)}$	Turn-On Delay Time <sup>3, 4</sup>	$V_{DD}=50\text{V}$ , $V_{GS}=10\text{V}$ , $R_G=6\Omega$ $I_D=1\text{A}$	---	14.6	30	ns
$T_r$	Rise Time <sup>3, 4</sup>		---	21.5	44	
$T_{d(off)}$	Turn-Off Delay Time <sup>3, 4</sup>		---	54	108	
$T_f$	Fall Time <sup>3, 4</sup>		---	84.3	168	
$C_{iss}$	Input Capacitance	$V_{DS}=25\text{V}$ , $V_{GS}=0\text{V}$ , $F=1\text{MHz}$	---	2590	3800	pF
$C_{oss}$	Output Capacitance		---	690	1000	
$C_{rss}$	Reverse Transfer Capacitance		---	120	180	
$R_g$	Gate resistance	$V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $F=1\text{MHz}$	---	1.43	---	$\Omega$

**Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current	$V_G=V_D=0\text{V}$ , Force Current	---	---	62	A
			---	---	124	A
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0\text{V}$ , $I_s=1\text{A}$ , $T_J=25\text{ }^{\circ}\text{C}$	---	---	1	V

Note :

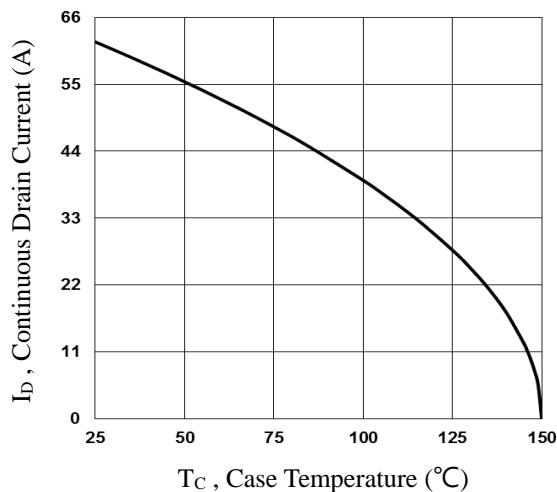
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2.  $V_{DD}=50\text{V}$ ,  $V_{GS}=10\text{V}$ ,  $L=0.1\text{mH}$ ,  $I_{AS}=65\text{A}$ ,  $R_G=25\Omega$ , Starting  $T_J=25\text{ }^{\circ}\text{C}$ .
3. The data tested by pulsed , pulse width  $\leq 300\text{us}$  , duty cycle  $\leq 2\%$ .
4. Essentially independent of operating temperature.



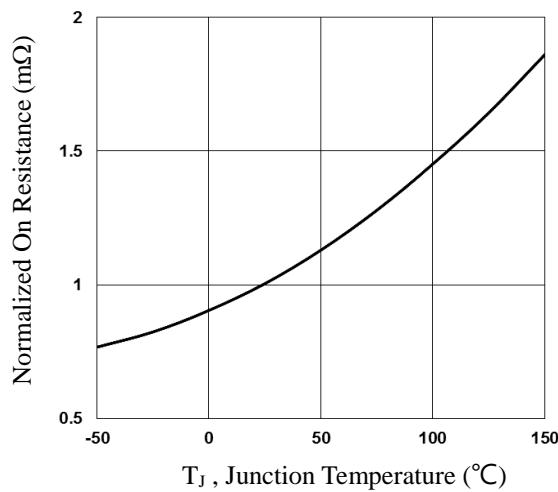
STEIF POWER  
TECHNOLOGY

100V N-Channel MOSFETs

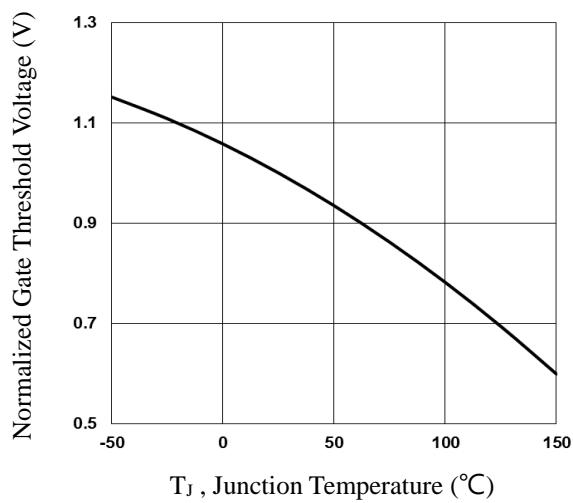
**SPC0976X**



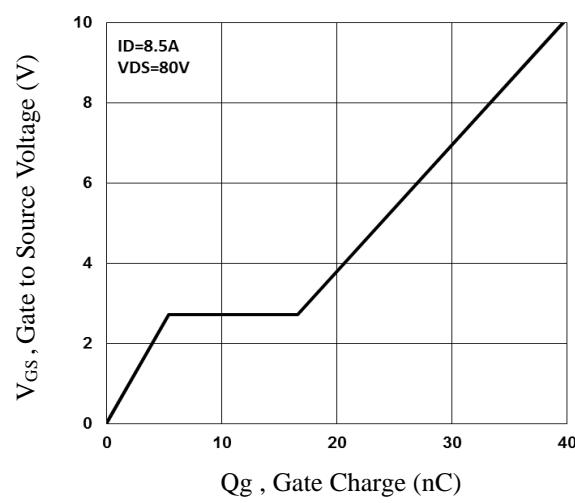
**Fig.1 Continuous Drain Current vs.  $T_C$**



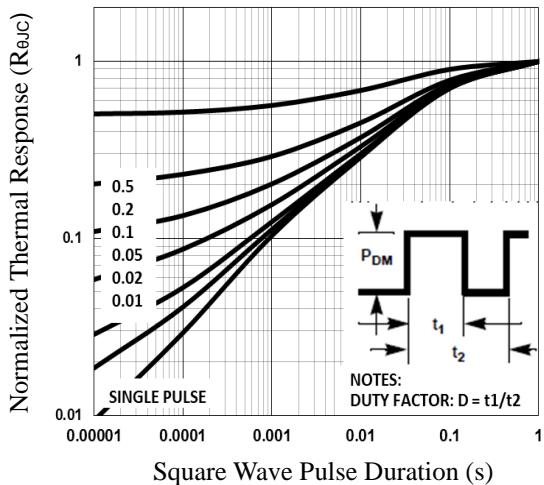
**Fig.2 Normalized RD<sub>SON</sub> vs.  $T_J$**



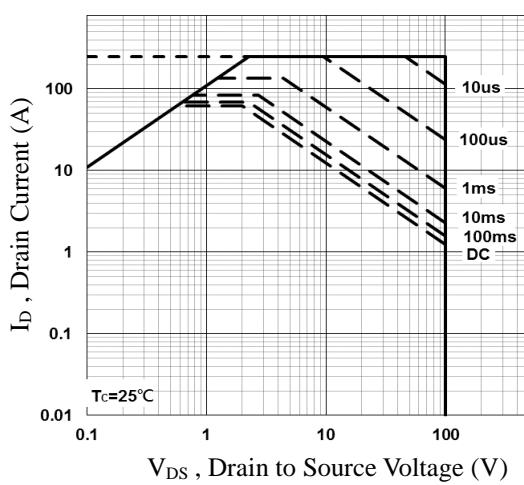
**Fig.3 Normalized V<sub>th</sub> vs.  $T_J$**



**Fig.4 Gate Charge Characteristics**



**Fig.5 Normalized Transient Impedance**



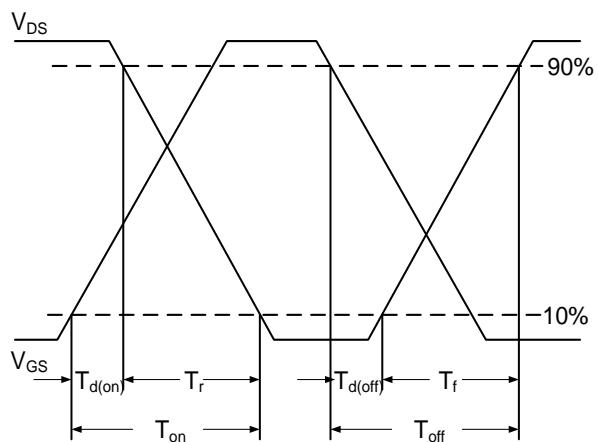
**Fig.6 Maximum Safe Operation Area**



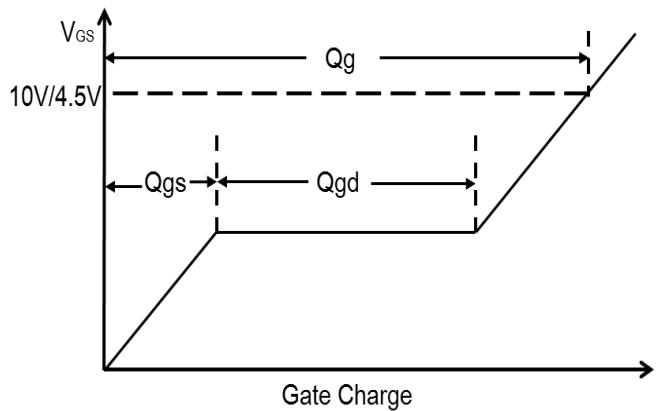
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100V N-Channel MOSFETs

**SPC0976X**



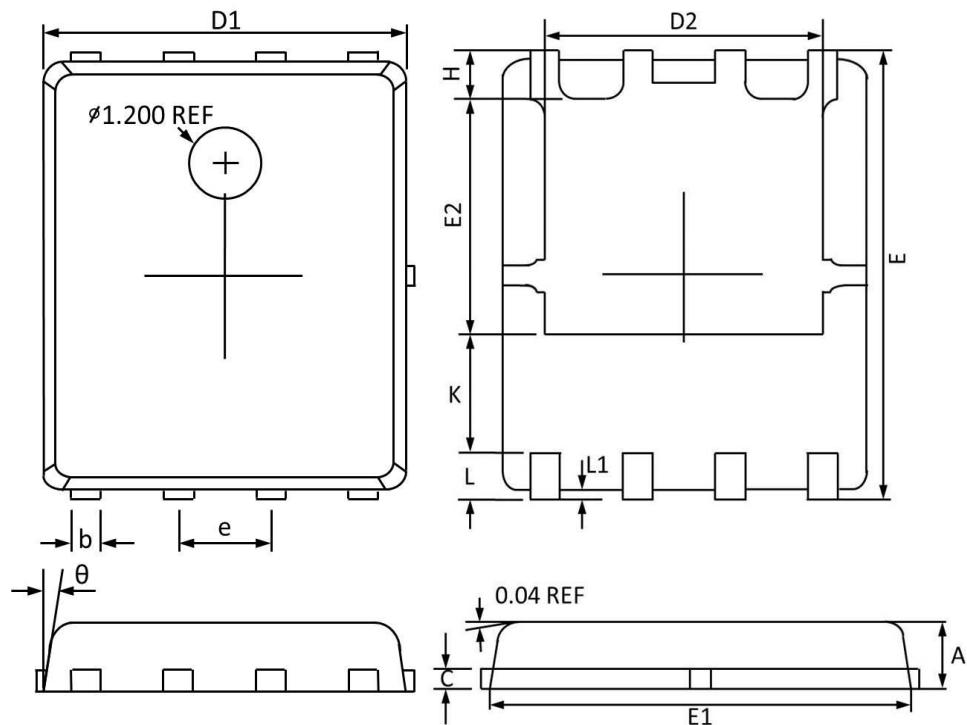
**Fig.7 Switching Time Waveform**



**Fig.8 Gate Charge Waveform**



## PPAK5X6 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	1.100	0.800	0.043	0.031
b	0.510	0.330	0.020	0.013
C	0.300	0.200	0.012	0.008
D1	5.100	4.800	0.201	0.189
D2	4.100	3.610	0.161	0.142
E	6.200	5.900	0.244	0.232
E1	5.900	5.700	0.232	0.224
E2	3.780	3.350	0.149	0.132
e	1.27BSC		0.05BSC	
H	0.700	0.410	0.028	0.016
K	1.500	1.100	0.059	0.043
L	0.710	0.510	0.028	0.020
L1	0.200	0.060	0.008	0.002
θ	12°	0°	12°	0°